

Special Issue

Tomography Sensors

Message from the Guest Editors

This Special Issue intendeds to provide a comprehensive overview of the current developments in process tomography applications, including but not limiting to instrumentation design, application of different tomographic techniques, hard/soft fields, multimodalities, and the use of tomography in new areas of application. This Special Issue will publish full research articles, reviews, and highly rated manuscripts addressing the above topics.

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Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

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